

12500 TI Boulevard, MS 8640, Dallas, Texas 75243

PCN#20200904000.1 Qualification of HFTF as an additional assembly site for select Devices Change Notification / Sample Request

Date: September 09, 2020 **To:** PREMIER FARNELL PCN

Dear Customer:

This is an announcement of a change to a device that is currently offered by Texas Instruments. The details of this change are on the following pages.

We request you acknowledge receipt of this notification within **30** days of the date of this notice. Lack of acknowledgement of this notice within 30 days constitutes acceptance of the change. If you require samples or additional data to support your evaluation, please request within 30 days.

The proposed first ship date is indicated on page 3 of this notification, unless customer agreement has been reached on an earlier implementation of the change.

This notice does not change the end-of-life status of any product. Should product affected be on a previously issued product withdrawal/discontinuance notice, this notification does not extend the life of that product or change the life time buy offering/discontinuance plan.

For questions regarding this notice, contact your local Field Sales Representative or the PCN Team (<u>PCN_ww_admin_team@list.ti.com</u>). For sample requests or sample related questions, contact your field sales representative.

Sincerely,

PCN Team SC Business Services

20200904000.1 Attachment: 1

Products Affected:

The devices listed on this page are a subset of the complete list of affected devices. According to our records, these are the devices that you have purchased within the past twenty-four (24) months. The corresponding customer part number is also listed, if available.

DEVICE	CUSTOMER PART NUMBER
SN74LVC2G125DCUT	null
SN74LVC2G132DCUR	null
SN74LVC1G123DCUR	null
SN74LVC1G125DBVR	null
SN74LVC1G04DCKR	null

Technical details of this Product Change follow on the next page(s).

PCN	Number:												
Title	Title: Qualification of HFTF as an additional assembly site for select Devices												
Cust	Customer Contact: PCN Manager Dept: Quality Services												
Proposed 1. Spin Hate: 1960 Hg 711711						Date provided at sample request							
Cha	nge Type:												
\boxtimes	Assembly Sit	е				Design)				Wafer B	lump Site	
	Assembly Pro					Data S	Sheet					Sump Material	
	Assembly Ma						umber c	hange			Wafer Bump Process		
	Mechanical S				Щ	Test Si				Щ	Wafer Fab Site		
\boxtimes	Packing/Ship	ping/	<u>'Labeli</u>	ng	Ш	Test Pr	rocess			<u>Н</u>		ab Materials	
						DON		•1 -			Wafer F	ab Process	
1						PCN	<u>Deta</u>	IIS					
Des	cription of C	nan	ge:										
site asse		sted be as t	oelow follows	in the p								alternate Assembly rences and current	
				SEWH			HIT		ŀ	INA	1	HFTF	
Moi	unt Compoun	d	112	20999A	2	F	RZ241C		40	018	30	SID# A-18	
_	d Compound	-		20039A			RM500F			017		SID#R-31	
-	d Finish	<u>'</u>		liPdAu	, т		1atte Sn				Matte Sn		
-			I					<u> </u>			\u		
Wir	e type			Au			Au			Au		Cu	
for t and G4 s	Upon expiry of this PCN TI will combine lead free solutions in a single <u>standard part number</u> , for the devices in group 2. For example; <u>SN74LVC1G04DCKR</u> – can ship with both Matte Sn and NiPdAu. When available customers may specify NiPdAu finish by ordering the part with the G4 suffix, e.g. SN74LVC1G04DCKRG4. " Example: - Customer order for 7500 units of <u>SN74LVC1G04DCKR</u> with 2500 units SPQ (Standard Pack Quantity per Reel). - TI can satisfy the above order in one of the following ways. I. 3 Reels of NiPdAu finish. II. 3 Reels of Matte Sn finish III. 2 Reels of Matte Sn and 1 reel of NiPdAu finish.												
1	IV. 2 Reels of NiPdAu and 1 reel of Matte Sn finish.												
	son for Char												
Supp	Supply continuity												
Anti	cipated imp	act o	n Fo	m, Fit,	Fι	ınction	, Qualit	ty or Reli	abi	ility	/ (positiv	ve / negative):	
None	None												
Anti					Dec	laratio	n						
	No Impact to the Material Declaration production data and will be available following the production release. Upon production release the revised reports can be obtained at the site link below http://www.ti.com/quality/docs/materialcontentsearch.tsp					the production reports can be							

Changes to product identification resulting from this PCN:

Assembly Site	Assembly Site Origin (22L)	Assembly Country Code (23L)	Assembly City
ASEWH	AWH	CHN	Weihai
HIT	HTC	JPN	Kitatsugaru
HNA	HNT	THA	Ayutthaya
HFTF	HFT	CHN	Hefei

Sample product shipping label (not actual product label)





(L)T0:1750

(1P) \$N74L\$07N\$R (Q) 2000 (D) 0336 (31T)LOT: 3959047MLA (4W) TKY(1T) 7523483812

(2P) REV: (V) 0033317 (20L) CSO: SHE (21L) CCO:USA (22L) ASO: MLA (23L) ACO: MYS

Product Affected:

SN74LVC1G04DCKR	SN74LVC1G123DCUR	SN74LVC2G125DCUR
SN74LVC1G06DCKR	SN74LVC1G125DBVR	SN74LVC2G125DCUT
SN74LVC1G07DCKR	SN74LVC1G125DBVT	SN74LVC2G132DCUR

Qualification Report

Approve Date 30-Oct-2019

Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Туре	Test Name / Condition	Duration	Qual Device: LSF0102DCUR	Qual Device: SN74LVC1G123DCUR
PC	PreCon Level 1	Level 1-260C	3/231/0	3/231/0
HAST	Biased HAST, 130C/85%RH	96 Hours	3/231/0	3/231/0
AC	Autoclave 121C	96 Hours	3/231/0	3/231/0
TC	Temperature Cycle, -65/150C	500 Cycles	3/231/0	3/231/0
HTSL	High Temp Storage Bake 170C	420 Hours	3/231/0	3/231/0
HTOL	Life Test, 125C	1000 Hours	3/231/0	3/231/0
LI	Lead Fatigue	Leads	3/66/0	-
LI	Lead Pull	Leads	3/18/0	-
MISC	Salt Atmosphere	24 Hours	3/66/0	-
SD	Surface Mount Solderability	PB	3/66/0	-
SD	Surface Mount Solderability	PB-Free	3/66/0	-
DS	Die Shear		3/30/0	3/30/0
PKG	Lead Finish Adhesion	Leads	3/45/0	-
WBP	Bond Pull	Wires	3/228/0	3/228/0

Туре	Test Name / Condition	Duration	Qual Device: LSF0102DCUR	Qual Device: SN74LVC1G123DCUR
WBS	Bond Shear	Wires	3/228/0	3/228/0
FLAM	Flammability (IEC 695-2-2)		3/15/0	-
FLAM	Flammability (UL 94V-0)		3/15/0	-
FLAM	Flammability (UL-1694)		3/15/0	-

- QBS: Qual By Similarity
- Qual Device SN74LVC1G123DCUR is qualified at LEVEL1-260CG
- Qual Device LSF0102DCUR is qualified at LEVEL1-260CG
- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
- The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
- The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles Quality and Environmental data is available at TI's external Web site: http://www.ti.com/Green/Pb-free Status:

Qualified Pb-Free(SMT) and Green

Qualification Report

Approve Date 09-Jun-2017

Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Туре	Test Name / Condition	Duratio n	Qual Device: SN74AHC1G14DBV R	Qual Device: SN74CBTLV1G125DBV R	Qual Device: SN74LVC1G17DBV R	Qual Device: TL431AIDBV R	Qual Device: TLVH431AIDBV R
AC	Autoclave 121C	96 Hours	3/231/0	3/231/0	3/231/0	2/154/0	1/77/0
AC	Autoclave 121C	144 Hours	3/231/0	3/231/0	3/231/0	2/154/0	1/77/0
FLA M	Flammability (IEC 695-2-2)		3/15/0	-	-	-	-
FLA M	Flammability (UL 94V-0)		3/15/0	-	-	-	-
FLA M	Flammability (UL-1694)		3/15/0	-	-	-	-
HAS T	Biased HAST, 130C/85%R H	96 Hours	3/231/0	3/231/0	3/231/0	2/154/0	1/77/0
HAS T	Biased HAST, 130C/85%R H	192 Hours	3/231/0	3/231/0	3/231/0	2/154/0	1/77/0
HTO L	Life Test, 150C	300 Hours	3/231/0	3/231/0	3/231/0	2/154/0	1/77/0
HTSL	High Temp. Storage Bake, 170C	400 Hours	3/231/0	3/231/0	3/231/0	2/154/0	1/77/0

HTSL	High Temp. Storage Bake, 170C	600 Hours	3/231/0	3/231/0	3/231/0	2/154/0	1/77/0
LI	Lead Fatigue	Leads	3/66/0	-	-	2/44/0	1/22/0
LFA	Lead Finish Adhesion	Leads	3/45/0	-	-	2/30/0	1/15/0
LI	Lead Pull to Destruction	Leads	3/66/0	-	-	2/44/0	1/22/0
PD	Physical Dimensions		3/15/0	-	-	2/10/0	1/5/0
SD	Solderability	Pb	3/66/0	-	-	2/44/0	1/22/0
SD	Solderability	Pb Free	3/66/0	-	-	2/44/0	1/22/0
TC	Temperature Cycle, - 65/150C	500 Cycles	3/231/0	3/231/0	3/231/0	2/154/0	1/77/0
TC	Temperature Cycle, - 65/150C	750 Cycles	3/231/0	3/231/0	3/231/0	2/154/0	1/77/0
DSS	Die Shear	Die	3/30/0	3/30/0	3/30/0	2/20/0	1/10/0
WBP	Bond Pull	Wires	3/228/0	3/228/0	3/228/0	2/152/0	1/76/0
WBS	Ball Bond Shear	Wires	3/228/0	3/228/0	3/228/0	2/152/0	1/76/0
MSL	Moisture Sensitivity Level	1-260C	3/36/0	-	-	2/24/0	1/12/0
SA	Salt Atmosphere	24 Hours	3/66/0	-	-	-	-
XR	X-Ray	(top side only)	3/15/0	3/15/0	3/15/0	2/10/0	1/5/0

- QBS: Qual By Similarity
- Qual Device SN74AHC1G14DBVR is qualified at LEVEL1-260C
- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
- The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
- The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles Quality and Environmental data is available at Tl's external Web site: http://www.ti.com/

Green/Pb-free Status:

Qualified Pb-Free(SMT) and Green

For questions regarding this notice, e-mails can be sent to the contacts shown below or your local Field Sales Representative.

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Asia Pacific	PCNAsiaContact@list.ti.com
WW PCN Team	PCN www admin_team@list.ti.com

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